

# MULTI-INNO TECHNOLOGY CO., LTD.

www.multi-inno.com

# **TOUCH PANEL SPECIFICATION**

Model : MI0700CLP-C

# For Customer's Acceptance:

Customer	
Approved	
Comment	

Revision	1.0
Engineering	
Date	2013-07-16
Our Reference	



# **REVISION RECORD**

REV NO.	REV DATE	CONTENTS	REMARKS
1.0	2013-07-16	Initial Release	



# **Table of Contents**

1.	COVER & CONTENTS	1
2.	RECORD OF REVISION	2
3.	APPLICATION	3
4.	GENERAL SPECIFICATIONS	3
5.	ABSOLUTE MAXIMUM RATINGS	3
6.	ELECTRICAL CHARACTERISTICS	4
7.	TIMING SPECIFICATIONS	4
8.	PIN CONNECTIONS	15
9.	BLOCK DIAGRAM ·····	15
10.	APPEARANCE SPECIFICATION	16
11.	QUALITY ASSURANCE ·····	20
12.	PRECAUTIONS IN USE CTP	21
13.	OUTLINE DRAWING	22



# **3. APPLICATION**

UMPC, POS, MID

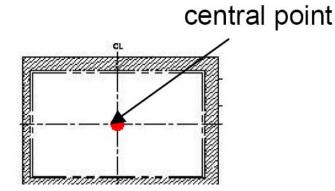
## 4. GENERAL SPECIFICATIONS

Composition: 7 inch Capacitive Touch Panel (CTP). Interface:  $I^2C$  for the CTP.

ltem	Specification	Unit
Туре	Transparent type projected capacitive touch panel	
Input mode	Human's finger	
Finger	5	
Outline Dimension	185.4(W) x 109.9(H) x 1.55(D)	mm
Sensor Active Area	154.6(W)(typ.) x92.4(H)(typ.)	mm
Transparency	≧85%	%
Haze	≦1.0%	%
Hardness	3H (typ.)[by JIS K5400]	Pencil hardness
Weight	41.6	g
Point hitting life time	1,000,000 times min.	Note 1

Note 1: Use 8 mm diameter silicon rubber/force 3N to knock on the same point twice per second

(no-operating), after test function check pass.



# 5. ABSOLUTE MAXIMUM RATINGS

Symbol	Description	Min	Тур	Max	Unit	Notes
VDD	Supply voltage	-0.3	-	3.6	V	
Vio	DC input voltage	-0.3	-	VDD+0.3	V	

Symbol	Description	Fingers	F <sub>scan</sub> (Hz)	Min	Тур	Max	Unit
VDD	Supply voltage			2.5	3.3	3.6	V
GND	Supply voltage			-	0	-	V
Vih	Input H voltage			0.8VDD	-	VDD	V
VIL	Input L voltage			0	-	0.2VDD	V
	System clock frequency					20	MHz
	CPU clock frequency					20	MHz
	Active mode	1	280		-	4	mA
		2	160		-	5	mA
I		3	90		-	5.2	mA
		4	80		-	5.4	mA
		5	75		-	5.6	mA
Isleep	Sleep mode	0	10		-	0.11	mA
Isleep	Deep sleep mode	-			-	50	uA
Ifreeze	Freeze mode	-			-	2	uA
	bootload	-			-	6.2	mA
	Calibration	-			-	6.2	mA

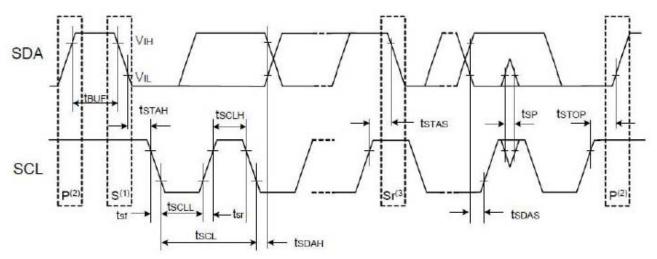
# **6. ELECTRICAL CHARACTERISTICS**

# 7. TIMING SPECIFICATIONS

# 7.1 CTP Interface and Data Format [Slave address is 0x5C ( 7 bit addressing )]

Communication protocol: I<sup>2</sup>C

Clock frequency: 100 KHz (400 KHz Fast mode)

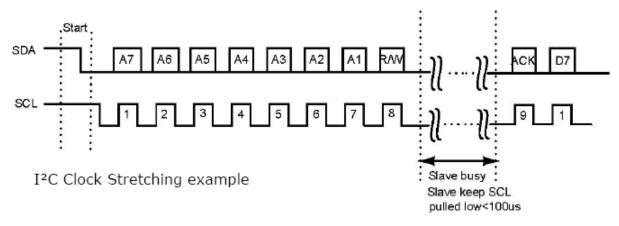






Ver	1.0

Symbol	Description	Min	Max	Unit
tSCL	SCL input cycle time	12tcyc+600	-	
tsclh	SCL input H width	3tcyc+300	-	
tSCLL	SCL input L width	5tcyc+500	-	
tSF	SCL, SDA input fall time		300	
tsp	SCL, SDA input spike pulse rejection time		1tcyc	
tsuF	SDA input bus-free time	5tcyc		ns
<b>t</b> STAH	Start condition input hold time	3tcyc		
<b>t</b> STAS	Retransmit start condition input setup time	3tcyc		
tSTOP	Stop condition input setup time	3tcyc		
tSDAS	Data input setup time	1tcyc+40		
<b>t</b> SDAH	Data Input hold time	10		1



The protocol for data exchange has been designed with the following considerations

1 Most of the data traffic is read operation to get the finger or fingers position

2 Read operation do need an initial write operation.

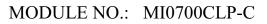
3 Write operations are most of the time power management and interrupt setting instructions

4 Interrupt pulse width setting adjustments need a write operation.

START
STOP
Acknowledge
No acknowledge
WRITE
READ
8-bit

From slave to Master

From Master to Slave





# 7.2 Timing Characteristic

## Read Operation

Read packets have variable content length, decided by the host. It is available to do a single read operation or a sequential read operation. Therefore, the beginning register address is need to set before a read operation. And the data sent exactly follow the register table 9, table 11, table 12, table 15. And, the firmware in the slave will use a memory copy of the register for I<sub>2</sub>C slave read operation, so that firmware can continue updates, and I<sub>2</sub>C slave is still using a consistent (but old) coordinates for read operation as below,



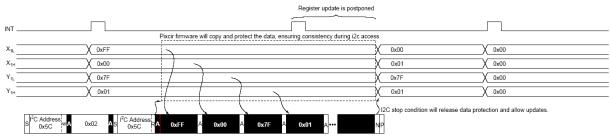
# Read operation

In a sequential read operation, the first data sent by the MSI device is therefore the touching register, and then the X and Y coordinates of the first finger, then 2nd finger, 3rd finger, 4th finger and then coordinates of the 5th finger, and so on. Refer in below.

0,00		5		· · · · · · · · · · · · · · · · · · ·
S I <sup>2</sup> C Address 0x5C	0x00 As I <sup>2</sup> C Address RA 0x5C	Data: A Data: A Data: A Data: A Data:	•••	• Data: Strength4 <sup>A</sup> Data: NP

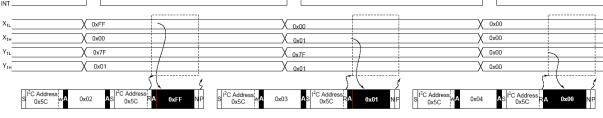
# Coordinates read operation

If the host does not finish the read operation when the INT line is set again, the slave firmware will delay to update coordinates registers for I<sup>2</sup>C read operation until the host finish the read operation referred to below



Received data is : X=0x00FF, Y=0x017F (correct)

I<sup>2</sup>C stop condition will release data protection and allow the slave firmware update the coordinates registers for I<sup>2</sup>C read operation. So, the host has the change to give incorrect data when it gets the coordinates data with single read operation. Because the host sends many times for I<sup>2</sup>C stop condition in each multi-fingers coordinate's position reading, it will give the slave firmware chance to update the coordinates registers for I<sup>2</sup>C read operation, the host will give a combine unrelated data combines new and old coordinates together, referred to below



I2C stop condition will release data protection and allow updates

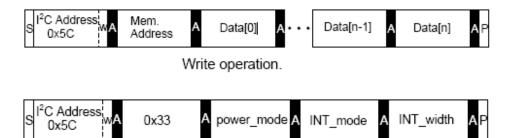
Received data is : X=0x01FF, Y=0x0000 incorrect because it combines unrelated data

Coordinates read operation explanation



## Write Operation

Write packets have variable content length, decided by the host. Write operation stops when host issues an I<sub>2</sub>C STOP symbol. The write packet is illustrated in Below. Following the I<sub>2</sub>C device address, the first byte of the write packet is always the destination register address, referred in table 9, table 11, table 12, table 15. Subsequent data values are written at the register pointed by the address, immediately upon reception of the byte. The address counter is automatically incremented. Subsequent data bytes are treated in continuation of the writing operation.



Write mode setting operation .

## Note1: MSI Registers

Address	Туре	Name	Description	Category
0	char	touching	Bitfield, see table 10	
1	char	buttons	Buttons bitfield	1
2 (lsb)	int	posx1	Finger #1 X position	1
3 (msb)				
4 (lsb)	int	posy1	Finger #1 Y position	1
5 (msb)				
6	char	id1	Finger #1 identificator	1
7 (Isb)	int	posx2	Finger #2 X position	]
8 (msb)				
9 (lsb)	int	posy2	Finger #2 Y position	1
10 (msb)				touch
11	char	id2	Finger #2 identificator	
12 (Isb)	int	posx3	Finger #3 X position	]
13 (msb)				
14 (Isb)	int	posy3	Finger #3 Y position	1
15 (msb)				
16	char	id3	Finger #3 identificator	]
17 (lsb)	int	posx4	Finger #4 X position	1
18 (msb)				
19 (lsb)	int	posy4	Finger #4 Y position	1
20 (msb)				
21	char	id4	Finger #4 identificator	1
22 (Isb)	int	posx5	Finger #5 X position	1
23 (msb)				
24 (lsb)	int	posy5	Finger #5 Y position	1
25 (msb)				
26	char	id5	Finger #5 identificator	]
27	char	strength1	Finger #1 strength	]
28	char	strength2	Finger #2 strength	]
29	char	strength3	Finger #3 strength	]
30	char	strength4	Finger #4 strength	]
31	char	strength5	Finger #5 strength	



Bit 0,1,2	Nb of fingers touching (NBF)
Bit 3	Noise flag (indicates the report is unreliable) (NOI)
Bit 4	message flag (indicates a message string is sent by slave) (MSG)
Bit 5	buffer indicates the master has missed more than 2 reports, which are
	stored in buffer array (BUF)
Bit 6	palm flag (indicates the algorithm has a palm or similar blocking issue) (PAL)
Bit 7	water flag, indicates the algorithm has a rejected inputs due to water (WAT)

Address	Туре	Name	Description	Category
32 (lsb) 33 (msb)	int	initial_distance	Distance separating fingers on the first time multitouch is detected	gesture
34 (lsb) 35 (msb)	int	distance	Distance separating fingers	
36 (lsb) 37 (msb)	int	ratio	100.distance / initial_distance	
38	char	water_level		1
39	char	noise_level		1
40	char	palm_level		monitor
41	char	signal_x		
42	char	signal_y		
43	char	button1	Signal level of the buttons	buttons
50		button8		
51	char	power_mode	Power management register. See §2.2.3 and table 16	power
52	char	INT_mode	Control of the ATTb pin, see §2.2.4 and table 17	management
53	char	INT_width	ATTb pulse width	1
54-57	char		reserved for future use	1
58	char	SPECOP	Special operation . See table 13	special
59 (lsb) 60 (msb)	int	EEPROM_read_ad	Address used during special operation	operations
61	char	Engineering_cmd	Allows, with I <sup>2</sup> c, to send "hyperterminal like commands" for engineering modes	
62 (lsb) 63 (msb)	int	CRC	FLASH CRC value (must be requested by SPECOP), excluding "EEPROM" zone	version
64-95	char	version[031]	Customer version control (32bytes) (imap to "eeprom")	



96-135	char	message[039]	Null terminated ASCII message string for engineering and debug purpose	
136 (lsb) 137 (msb)	int	RAW_CTRL	Controls RAW data mode (internal, raw, etc) see table 14	
138	char	cross_x	X coordinate for method 1 crossing node measurement request	method 1
139	char	cross_y	Y coordinate for method 1 crossing node measurement request	metrod i
140 (lsb) 142 (msb)	int	cross_node	Measurement result for method 1	
142 (lsb) 143 (msb)	int	RAW[069]	Raw data, content controlled by RAW_CTRL register, or alternatively, history buffer (see below)	RAW data
144 (lsb) 145 (msb)	int	shared with	Delow)	
etc.	int	history_buffer		

0	Normal operation
1	"EEPROM" read operation, start address must be written in EEPROM_read_addr
2	"EEPROM" write operation NOT IMPLEMENTED
3	Calibration
4	CRC checksum of the application in Flash

Bit 0	Chapped function (0) history huffer 1: DAVA(date 2) system info) See table 15
Bit 1	Choose function (0: history buffer, 1: RAW data, 2: system info) See table 15
Bit 2	Method (0 0r 1)
Bit 3	Show offset correction (and low-pass fiter for M0)
Bit 4	Show m0 sensitivity adjustment (bit3 must also be set)
Bit 5	M1 pattern small (0) or pattern large (1)
Bit 6	M1 sense direction (0:Y,1:X)
Bit 7	M1 band scan. if 0, only report a single cross node. If 1,report a full X axis
	scan at RAW position
Bit 8	Disable Algorithm
Bit 9	Enable single shot RAW refresh, must be set to 1 and bit9 to 0. Auto back to
	0 and bit9 to 1 after single shot is done
Bit 10	Refresh frozen after single shot is done when 1. Set to 0 to release the
	freeze and go back to normal refreshing
Bit 11	
Bit 12	
Bit 13	
Bit 14	
Bit 15	



Address	Туре	Name	Description	Category
142	char	interval	Subsampling rate when filling the history buffer. Disable: 0. Keep all points: 1. Keep one out of two: 2. Etc.	history buffer
143	char	buffer_level	Number of fingers report in the buffer	
144 (lsb) 145 (msb)	int	posx	Coordinate X of the reported point, at time=0	
146 (lsb) 147 (msb)	int	posy	Coordinate Y of the reported point, at time=0	
148 (lsb) 149 (msb)	int	posx	Coordinate X of the reported point at time=1	
150 (lsb) 151 (msb)	int	posy	Coordinate Y of the reported point at time=1	
298 (lsb) 299 (msb)	int	posx	Coordinate X of the reported point, at time=19	
300 (lsb) 301 (msb)	int	posy	Coordinate Y of the reported point, at time=19	

# 7.3 Operating Mode Register

# 7.3.1 POWER\_MODE Register

Address	Name	Description of POWER_MODE Register
7-4		Refer to ALLOW_SLEEP function description
		Idle_period_time = k * 16 * Active_scan_period_time [s], with
	IDLE_PERIOD[3-0]	k = value of IDLE_PERIOD[3-0]
		Active_scan_period_time = duration [s] of a scan period in active
		mode.
3	-	Not used
2	ALLOW_SLEEP	Allow self demotion from active to sleep mode, provide that this flag is set. If the MSI device is in active mode and no fingers is detected for more than IDLE_PERIOD time, then it allow AUTO JUMP to sleep mode. If this flag is not set, the host must explicitly switch the device from active to sleep mode.
1-0	POWER_MODE[1-0]	Power mode setting of the MSI device: 00:Active Mode 01:Sleep Mode 10:Deep Sleep Mode 11:Freeze Mode

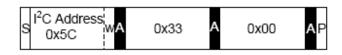


Address	Name	Description		
7-4	- Not used			
3	EN_INT	0:disable interrupt mode 1:enable interrupt mode		
2	INT_POL 0:the interrupt is low active(default) 1:the interrupt is high active			
1-0	INT_MODE[1-0]	00:INT assert periodically 01:INT assert only when finger moving 10:INT assert only when finger touch(default)		

## 7.3.2 INT\_MODE Register

#### 7.3.3 Power management Active mode

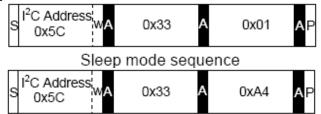
In this mode, the slave resumes with a new scan directly after each I<sup>2</sup>C transfer (after INT rising edge). This is used to reach the highest refresh rate, but also has the highest current consumption. Below shows how to force the slave into Active mode.



## Active mode sequence

## Sleep mode

This mode is selected to decrease the current consumption during low activity phases on the sensor, which need a lower refresh rate(10Hz). The MSI can automatically switch to Active mode(when finger is detected, provided that ALLOW\_SLEEP bit is set in the POWER\_MODE register) or by set POWER\_MODE register. Also, the MSI can automatically switch from Active to Sleep mode when no finger is detected for more than IDLE\_PERIOD time, provided that ALLOW\_SLEEP bit is set in the POWER\_MODE register. Figure 44 shows how to force the slave into Sleep mode. Below shows how to force the slave into Sleep mode can automatically switch, provided IDLE\_PERIOD=10.

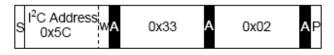


Sleep mode automatically switch sequence

## Deep Sleep mode

This mode is selected to acheive the minimum consumption during very low activity phases on the sensor, which need a lowest refresh rate (1Hz). The MSI only can switch to Deep Sleep mode by set POWER\_MODE register. Below shows how to force the slave into Deep Sleep mode.





Deep Sleep mode sequence

### Freeze mode

In this mode, the slave MCU internal clock source is stopped, and consumption is only MOS leakage. Below shows how to force the slave into Freeze mode. There are two ways to wake up from freeze mode.

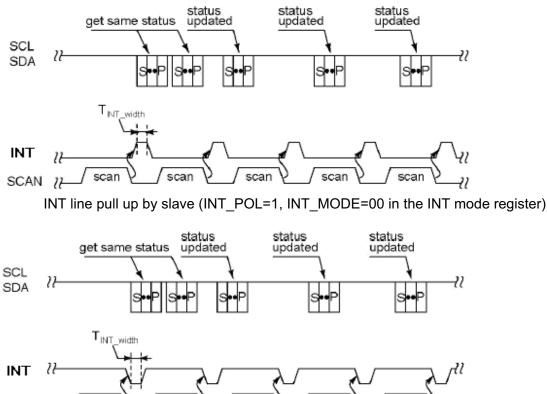
- RST pin pull down (connect to the Ground) (default)
- INT pin change ("1 to 0" or "0 to 1")



Freeze mode sequence

## 7.3.4 Transition of INT line

When INT\_MODE=00 in the INT MODE register, the slave will set the INT line with INT\_width pulse width after each scan in order to request the attention from the host, as shown in below



scan

INT line pull down by slave (INT POL=0, INT MODE=00 in the INT mode register)

scan

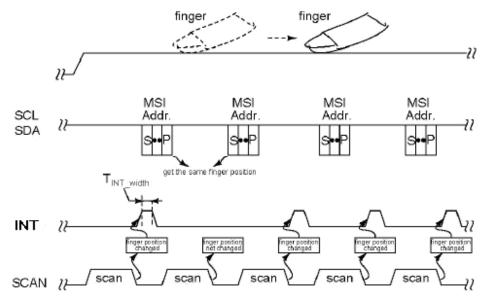
scan

scan

SCAN 77

scan

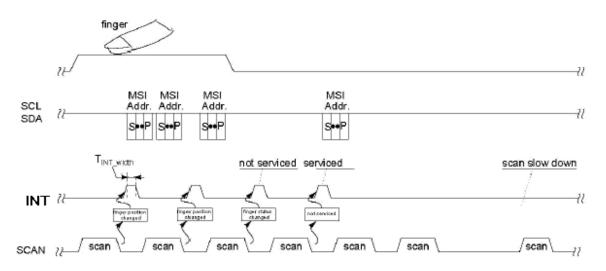




When INT\_Mode=01 in the INT mode register and finger moving on the panel, the slave will set The INT line after each scan, as shown in below.

INT line pull up when finger moving (INT\_POL=1, INT\_MODE=01 in the INT mode register)

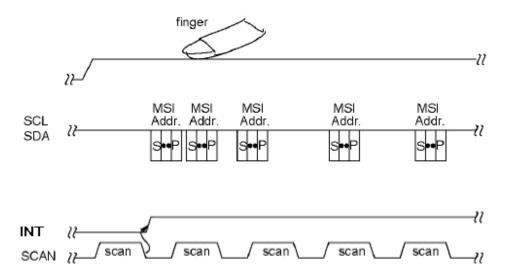
When fingers leaves the panel, the slave will continue to pulse INT line for each scan; but once the master has serviced this request and become now aware that there is no more finger touching, the slave will stop pulse the INT line, and will also gradually reduce the scan speed, as shown in below



INT line will stop pulse when finger leaves and master has acknowledge the situation (INT\_POL=1 in the INT mode register)

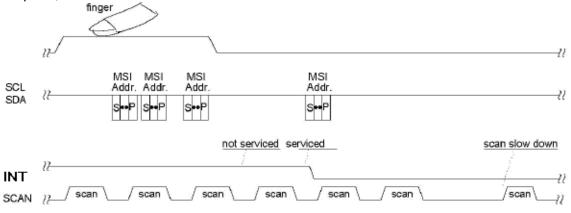
When INT\_Mode=10 in the INT mode register and finger touch the panel, the slave will set The INT line after each scan as shown in below.





INT line pull up when finger touch (INT\_POL=1, INT\_MODE=10 in the INT mode register)

When fingers leaves the panel, the slave will continue keep INT line status for each scan; but once the master has serviced this request and become now aware that there is no more finger touching, the slave will release the INT line, and will also gradually reduce the scan speed, as shown in below



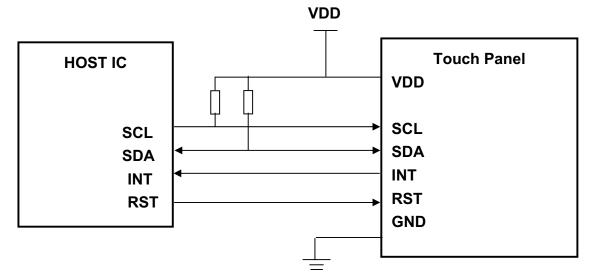
INT line will stop pulse when finger leaves and master has acknowledge the situation (INT\_POL=1 in the INT mode register)



# **8. PIN CONNECTIONS**

No.	Name	I/O	Description
1	SDA	I/O	Serial data access
2	SCL	I	Clock; 100KHz
3	RST	I	Reset
4	INT	0	Active low when data output from touch panel
5	VDD	-	Power; VDD=3.3V(typ.)
6	GND	-	Ground

# 9. BLOCK DIAGRAM



Note : 1. USE APPROPRIATE RESISTOR VALUE DURING HIGH SPEED SCL CLOCK.

SUGGESTION : RESISTOR RECOMMENDATION : 1K ohm.

2. To reduce the noise from the power, we suggest you use the independent power for the touch panel (VDD)

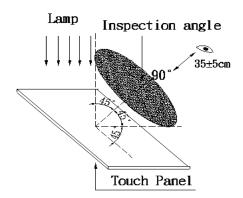


# **10. Appearance Specification**

# 10.1 Process/Content:

- 10.1.1Inspection equipment: fluorescent lamp, functional test jig, magnifying glass, Vernier caliper, ESD wrist strap.
- 10.1.2 Environment demand
  - 1.2.1 Temperature :  $25\pm5^{\circ}C$
  - 1.2.2 Humidity : 30-75%RH
  - 1.2.3 Luminance : Fluorescent light (appearance : 800-1200UXL function : 100-500UXL)
- 10.1.3 Inspection process
  - 1.3.1 Inspect distribution operation
  - 1.3.2 Shift team leader is in charge of distributing work when work order goes to OQC inspection of finished products
  - 1.3.3 Products of great emergency or especially asked by customer should be finished in advance.
  - 1.3.4 All the items should be fully inspected before shipment.
  - 1.3.5 The inspection standard & specification should be carried out according to customer's demand. If customer has no other standard & specification, just stick to this one.
- 10.1.4 Sampling plan
  - 1.4.1 Do tests regularly according to MIL-STD-105E. Single sampling plan is arrived out according to Level  $\Pi$ .
  - 1.4.2 Defect definition
    - 1.4.2.1 Major defect is inspected according to AQL 0.65%.
    - 1.4.2.2 Minor defect is inspected according to AQL 1.0%.
- 10.1.5Appearance inspection
  - 1.5.1 Appearance inspection method

Inspection angle spacing : 30-40cm





Item	Spec	2	Statement
	Spec	Q'ty allowed	
Foreign material	D>0.8mm	0	
Punctiform	0.3mm≦D≦0.8mm	5	D= (L + W) / 2
	D<0.3mm	Disregarded	
	Spec	Q'ty allowed	I I I
Foreign material	W>0.1mm L> 10mm	0	W
Linear	0.05mm≦W≦ 0.1mm L≤10mm	5	L : Long W : Width
	W<0.05mm	Disregarded	
Image uniformity	Gray color can be seen on RGB through ND5%		

# 1.5.2 Appearance inspection standard

	Spec	Q'ty allowed	$\sim$
TP scratch	W>0.1mm L>10mm	0	
	W≦0.1mm L≦10mm	5	L
	Spec	Q'ty allowed	
TP dented spot	D>0.8mm	0	L D= (L + W) / 2
	0.3mm≦D≦0.8mm	5	
TP overflows or lacks of glue	±0.45mm		



Surface broken	X<2mm Y<2mm Z <glass< td=""><td></td></glass<>	
Edge broken	X<2mm Y<2mm Z <glass< td=""><td></td></glass<>	
Rift	Not allowed	1 million
Bubble appears in protection film	D>10mm N=0 $5 \le D \le 10$ mm N=2 D<5 disregarded	
TP deviation	According to the specifications of customer's drawing	
	D≦0.3mm disregarded	
	0.3mm <d≤0.5mm n≤3<="" td=""><td></td></d≤0.5mm>	
Bubble	0.3mm <d allowed<="" not="" td=""><td></td></d>	
	No influence on appearance and function in invisible area OK	
	No light leak	
	Silk-screen saw tooth∶S≦0.1 disregarded	
Printing ink	0.1mm≤S≤0.15mm N=5 S>0.15 ng	
	LOGO break line NG	
	Script dim, printed backwards , no printing in wrong place	
Finger print	Not allowed	
	Stain on surface can be removed OK	
Stain	Bonding surface has no influence on appearance and function OK	
	Can't be removed & not allowed	
	Bent isn't allowed	
Protection film	No lift up	
	Bent is allowed L<10MM $$ N ${\leq}5$	



## 11. QUALITY ASSURANCE 11.1 Test Condition

11.1.1 Temperature and Humidity(Ambient Temperature)

Temperature	:	$25\pm5^{\circ}C$
Humidity	:	$65 \pm \mathbf{5\%}$

11.1.2 Operation

Unless specified otherwise, test will be conducted under function state.

11.1.3 Container

Unless specified otherwise, vibration test will be conducted to the product itself without putting it in a container.

11.1.4 Test Frequency

In case of related to deterioration such as shock test. It will be conducted only once.

11.1.5 Test Method	11	.1.5	Test	Method
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	Reliability Test Item & Level	Test Level
No.	Test Item	
1.	High Temperature Storage Test	T= 70 $^\circ$ C , 120hrs after 1 hrs at room temperature and test.
2.	Low Temperature Storage Test	T= -20 $^\circ\!\mathrm{C}$ , 120hrs after 1 hrs at room temperature and test.
3.	High Temperature and High Humidity Storage Test	T= 40℃, 90%RH,120hrs after 24 hrs at room temperature and test.
	Thermal Cycling Test (No operation)	-20 $^\circ\!\!C$ 30min ~ 70 $^\circ\!\!C$ 30 min , 100 Cycles after 24 hrs at room temperature and test.
5.	Vibration Test (No operation)	Frequency :10 ~ 55 HZ Amplitude :1.5 mm Sweep time : 11 mins Test Period: 6 Cycles for each direction of X, Y, Z
6.	ESD TEST	Air Discharge:±8KV Indirect Contact Discharge:±4KV



## **12. PRECAUTIONS IN USE CTP**

#### 1. ASSEMBLY PRECAUTIONS

- Since Touch Panel is consist of glass, please be careful your hands to be injured during handing. You must wear gloves during handing.
- (2) Do not touch, push or rub the exposed touch panel, tweezers or anything harder than HB pencil lead. And please do not rub with dust clothes with chemical treatment.
- (3) Do not stack the touch panels together.Do not put heavy objects on touch panel.
- (4) Please do not take a CTP to pieces and reconstruct it. Resolving and reconstructing modules may cause them not to work well.
- (5) Please excessive force or strain to the panel or tail is prohibited, Do not lift touch panel by cable(FPC).
- (6) Use clean sacks or glove to prevent fingerprints and/or stains left on the panel. Extra attention and carefulness should be taken while handling the glass edge.
- (7) Please pay attention for the matters stated below at mounting design of touch panel enclosure. Enclosure support to fix touch panel must be out of active area.(do not design enclosure presses the active area to protect from miss put)
- 2. OPERATING PRECAUTIONS
  - (1) Please be sure to turn off the power supply before connecting and disconnecting signal input cable.
  - (2) Please do not change variable resistance settings in CTP. They are adjusted to the most suitable value. If they are changed, it might happen CTP does not satisfy the characteristics specification
  - (3) Be careful for condensation at sudden temperature change. Condensation makes damage to snesor or electrical contacted parts.
  - (4) CTP has high frequency circuits. Sufficient suppression to the electromagnetic interference shall be done by system manufacturers. Grounding and shielding methods may be important to minimize the interference.
  - (5) Touch the panel with your finger or stylus only to assure normal operation. Any sharp edged or hard objects are prohibited.
  - (6) Operate the panel in a steady environment. Abrupt variation on temperature and humidity may cause malfunction of the panel.
- 3. ELECTROSTATIC DISCHARGE CONTROL
  - (1) The operator should be grounded whenever he/she comes into contact with the CTP. Never touch any of the conductive parts such the copper leads on the FPC and the interface terminals with any parts of the human body.

- (2) The CTP should be kept in antistatic bags or other containers resistant to static for storage.
- (3) Only properly grounded soldering irons should be used.
- (4) If an electric screwdriver is used, it should be well grounded and shielded from commutator sparks.
- (5) The normal static prevention measures should be observed for work clothes and working benches; for the latter conductive (rubber) mat is recommended
- (6) Since dry air is inductive to statics, a relative humidity of 50-60% is recommended.

STORAGE PRECAUTIONS

- (1) When you store touch panel for a long time, it is recommended to keep the temperature between 0°C-40°C without the exposure of sunlight and to keep the humidity less than 90%RH.
- (2) Please do not leave touch panel in the environment of high humidity and high temperature such as 60°C 90%RH
- (3) Please do not leave touch panel in the environment of low temperature; below -20°C.

#### 5. OTHERS

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- For the packaging box, please pay attention to the followings: a. Please do not pile them up more than 5 boxes. (They are not
- designed so.) And please do not turn over.b. Please handle packaging box with care not to give them sudden shock and vibrations. And also please do not throw
- them up.c. Packing box and inner case for CTP are made of cardboard. So please pay attention not to get them wet. (Such like keeping them in high humidity or wet place can occur getting them wet.)

#### LIMITED WARRANTY

Unless otherwise agreed between MULTI-INNO and customer, MULTI-INNO will replace or repair any of its CTP which is found to be defective electrically and visually when inspected in accordance with MULTI-INNO acceptance standards, for a period on one year from date of shipment. Confirmation of such date shall be based on freight documents. The warranty liability of MULTI-INNO is limited to repair and/or replacement on the terms set forth above. MULTI-INNO will not responsible for any subsequent or consequential events.



# **13. OUTLINE DRAWING**

